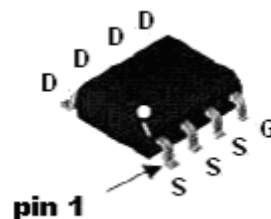


P-Channel Enhancement Mode Power MOSFET

SOP-8

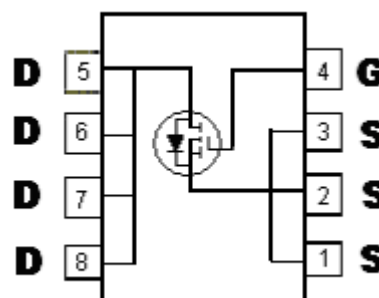
Features:

- Simple drive requirement
- Low on-resistance
- Fast switching speed
- Pb-free and halogen-free package



	-30V
ID@VGS=-10V, TA=25°C	-20A
ID@VGS=-4.5V, TA=25°C	-16A
ID@VGS=-10V, TC=25°C	-28A
ID@VGS=-4.5V, TC=25°C	-22A
RDSON@VGS=-10V, ID=-20A	3.0mΩ (typ)
RDSON@VGS=-4.5V, ID=-17A	4.2mΩ (typ)

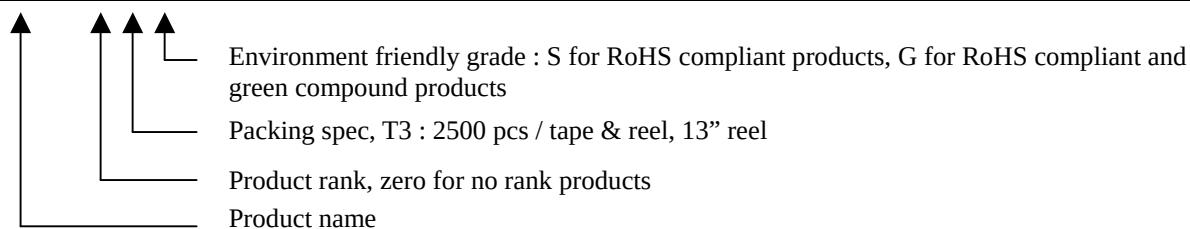
KWB5D0P03Q8



G : Gate
 S : Source
 D : Drain

Ordering Information

Device	Package	Shipping
KWB5D0P03Q8-0-T3-G	SOP-8 (Pb-free lead plating and halogen-free package)	2500 pcs / tape & reel



Absolute Maximum Ratings (T_C=25°C, unless otherwise noted)

Parameter	Symbol	Limits	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	-30	V
Gate-Source Voltage	V _{GS}	±25	
Continuous Drain Current @T _A =25 °C , V _{GS} =-10V	I _{DSM}	-20	A
Continuous Drain Current @T _A =70 °C , V _{GS} =-10V		-16	
Continuous Drain Current @T _A =25 °C , V _{GS} =-4.5V		-16	
Continuous Drain Current @T _A =70 °C , V _{GS} =-4.5V		-12.8	
Continuous Drain Current @T _C =25 °C , V _{GS} =-10V	I _D	-28	
Continuous Drain Current @T _C =100 °C , V _{GS} =-10V		-17.7	
Continuous Drain Current @T _C =25 °C , V _{GS} =-4.5V		-22	
Continuous Drain Current @T _C =100 °C , V _{GS} =-4.5V		-13.9	
Pulsed Drain Current (Note 1)	I _{DM}	-120	
Avalanche Current	I _{AS}	-50	
Avalanche Energy @ L=0.1mH, I _D =-50A, V _{DD} =-25V	E _{AS}	125	mJ
Power Dissipation	P _D	T _C =25 °C	W
		T _C =100 °C	
Power Dissipation (Note 2)	P _{DSM}	T _A =25 °C	
		T _A =70 °C	
Operating Junction and Storage Temperature Range	T _j ; T _{stg}	-55~+150	°C

Note : 1.Pulse width limited by maximum junction temperature.

2.Surface mounted on 1 in² copper pad of FR-4 board, t≤10s.

Thermal Resistance Ratings

Thermal Resistance	Symbol	Maximum	Unit
Junction-to-Case	R _{θJC}	20	°C / W
Junction-to-Ambient (Note)	R _{θJA}	40	

Note : When mounted on a 1 in² pad of 2 oz copper, t≤10s; 125°C/W when mounted on minimum copper pad. The value in any given application depends on the user's specific board design.

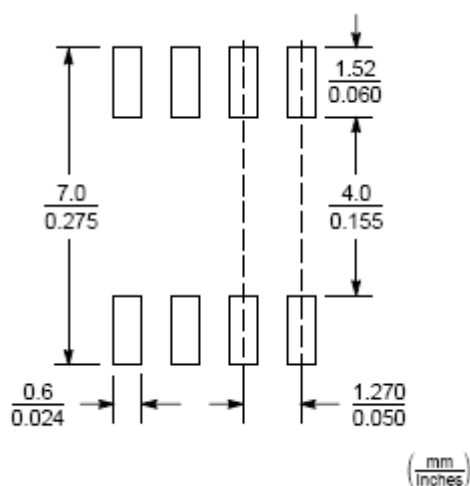
Electrical Characteristics (T_C=25°C, unless otherwise noted)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	-30	-	-	V	V _{GS} =0V, I _D =-250μA
ΔBV _{DSS} /ΔT _j	-	-12	-	mV/°C	I _D =-250μA, referenced to 25°C
V _{GS(th)}	-1	-	-2.5	V	V _{DS} =V _{GS} , I _D =-250μA
I _{GSS}	-	-	±100	nA	V _{GS} =±25V, V _{DS} =0V
I _{DSS}	-	-	-1	μA	V _{DS} =-30V, V _{GS} =0V
I _{DSS}	-	-	-10		V _{DS} =-24V, V _{GS} =0, T _j =125°C
R _{DS(ON)} (Note 1)	-	3	4.5	mΩ	I _D =-20A, V _{GS} =-10V
	-	4.2	6.5		I _D =-17A, V _{GS} =-4.5V

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
G _{FS} (Note 1)	-	59	-	S	V _{DS} =-5V, I _D =-20A
Dynamic					
C _{iss}	-	6458	-	pF	V _{DS} =-15V, V _{GS} =0V, f=1MHz
C _{oss}	-	849	-		
C _{rss}	-	402	-		
t _{d(ON)} (Note 1&2)	-	23.8	-	ns	V _{DS} =-15V, I _D =-1A, V _{GS} =-10V, R _G =6Ω
t _r (Note 1&2)	-	25.6	-		
t _{d(OFF)} (Note 1&2)	-	187.2	-		
t _f (Note 1&2)	-	69.4	-		
Q _g (Note 1&2)	-	113	-	nC	V _{DS} =-15V, I _D =-20A, V _{GS} =-10V
Q _{gs} (Note 1&2)	-	19.6	-		
Q _{gd} (Note 1&2)	-	19.6	-		
R _g	-	3	-	Ω	f=1MHz
Source-Drain Diode					
I _S	-	-	-2.1	A	
I _{SM} (Note 3)	-	-	-8.4		
V _{SD} (Note 1)	-	-0.69	-1	V	I _S =-2.1A, V _{GS} =0V
t _{rr}	-	28.4	-	ns	I _F =-20A, dI _F /dt=100A/μs
Q _{rr}	-	20.8	-	nC	

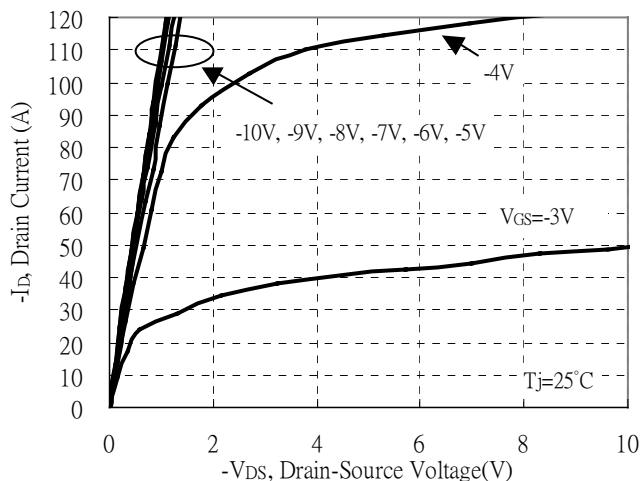
Note : 1.Pulse Test : Pulse Width $\leq 300\mu s$, Duty Cycles $\leq 2\%$
2.Independent of operating temperature
3.Pulse width limited by maximum junction temperature

Recommended Soldering Footprint

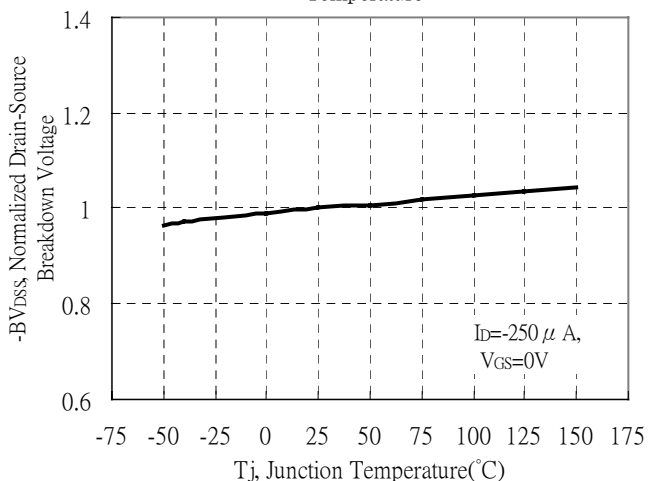


Typical Characteristics

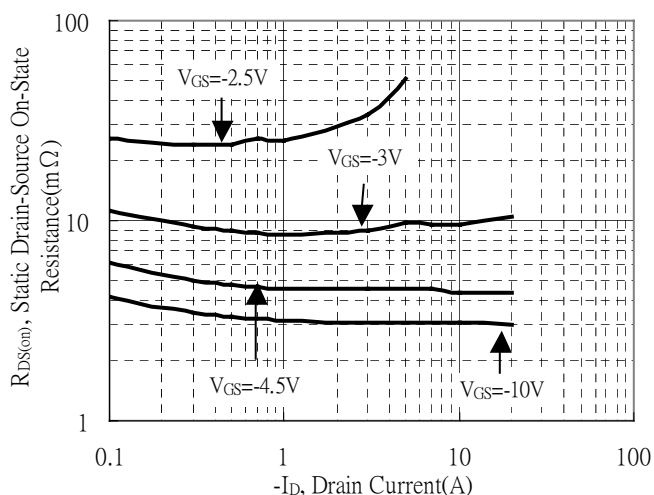
Typical Output Characteristics



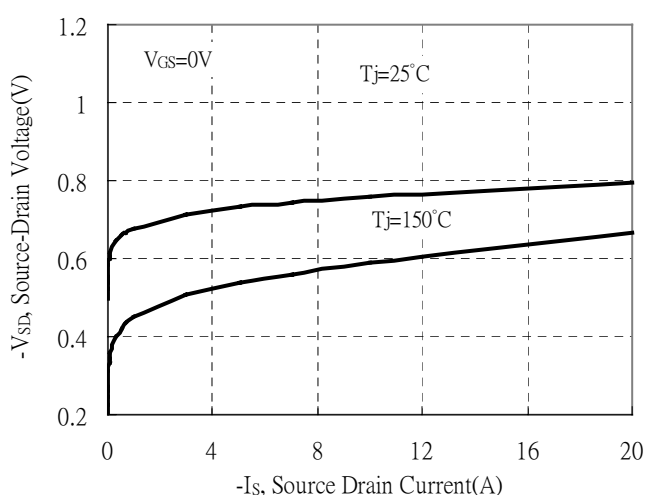
Normalized Brekdown Voltage vs Ambient Temperature



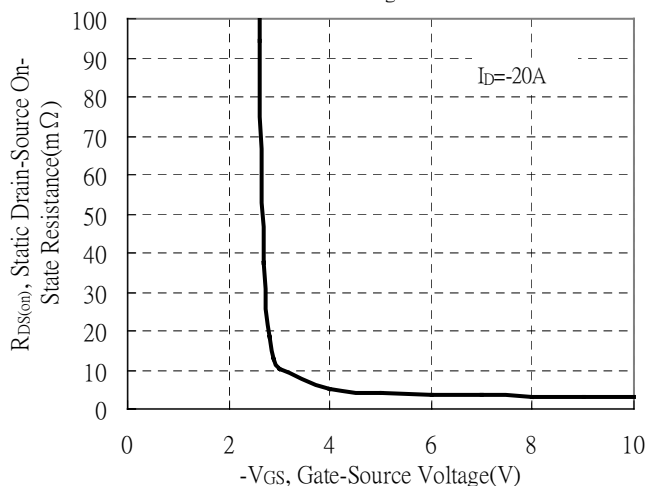
Static Drain-Source On-State resistance vs Drain Current



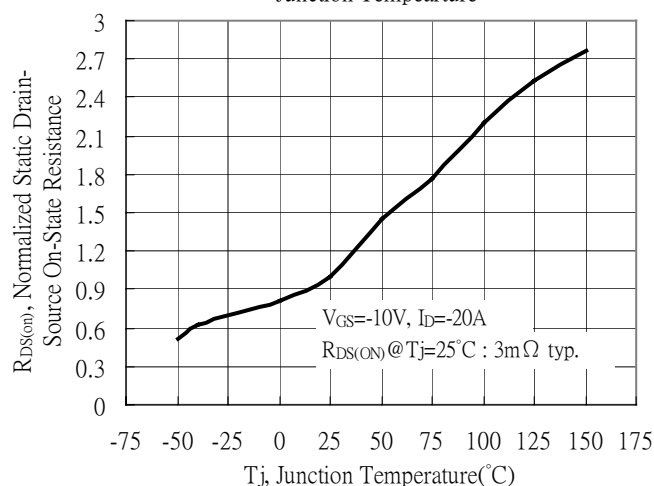
Source Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

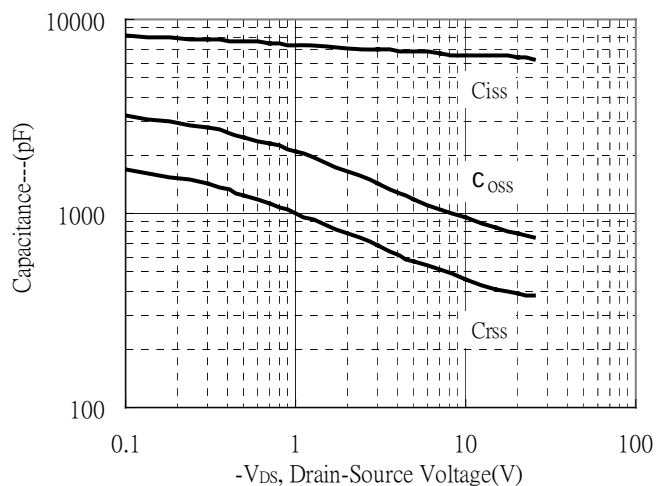


Normalized Drain-Source On-State Resistance vs Junction Temperature

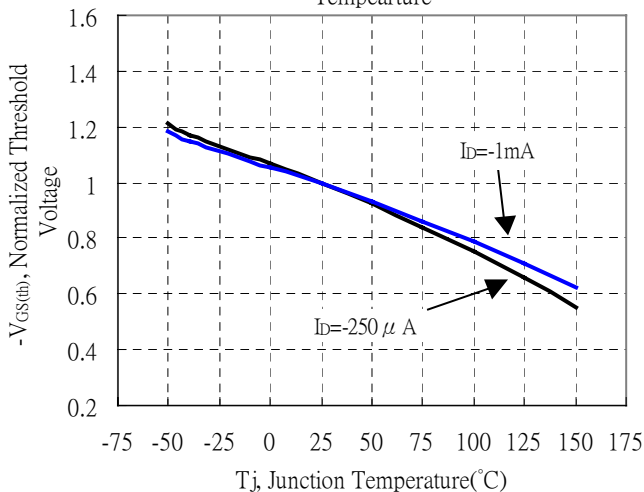


Typical Characteristics(Cont.)

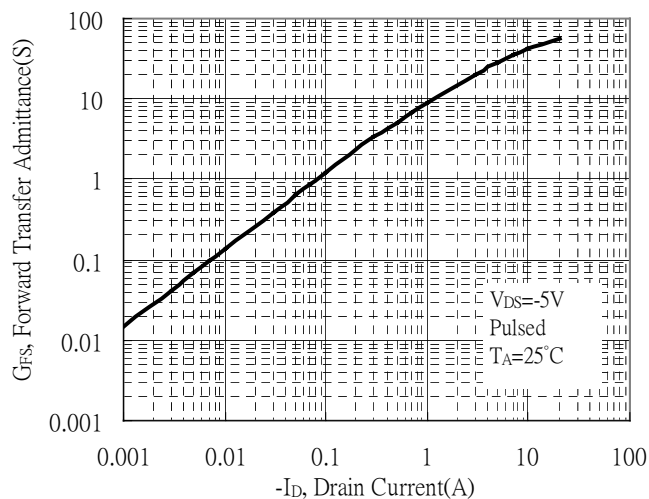
Capacitance vs Drain-to-Source Voltage



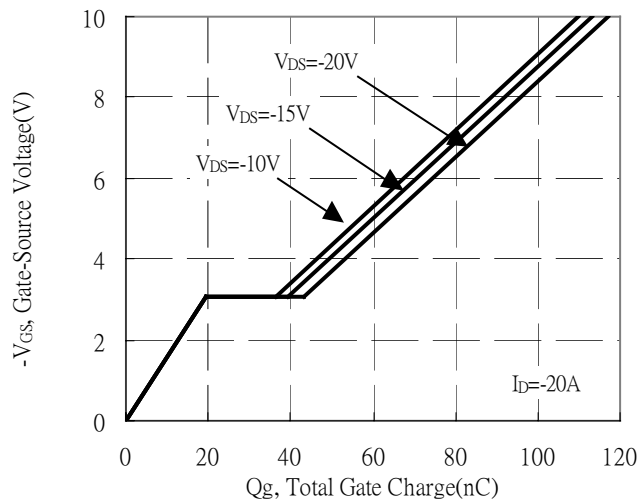
Normalized Threshold Voltage vs Junction Temperature



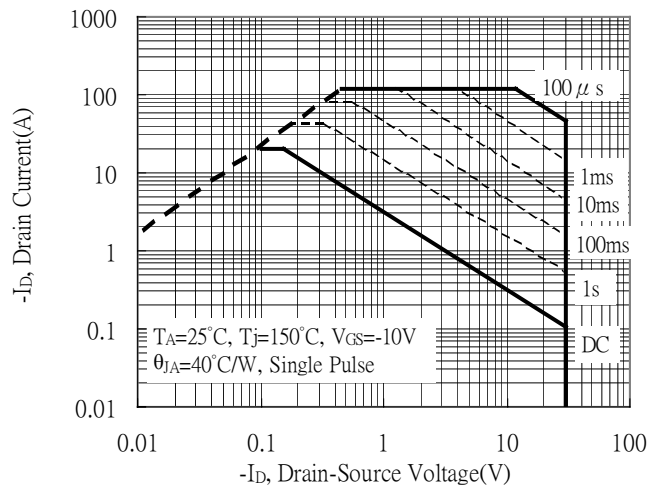
Forward Transfer Admittance vs Drain Current



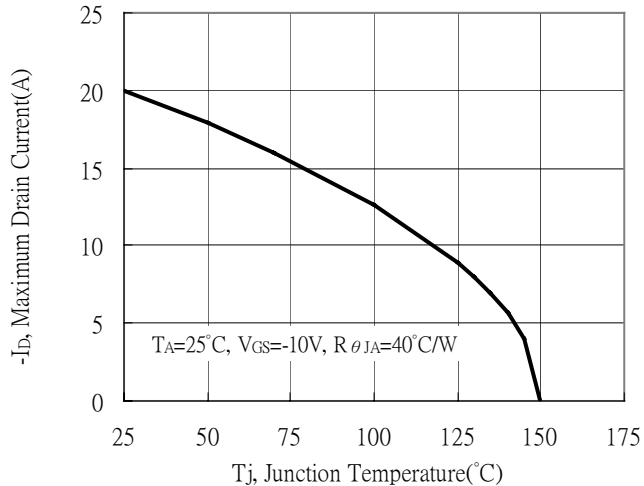
Gate Charge Characteristics



Maximum Safe Operating Area

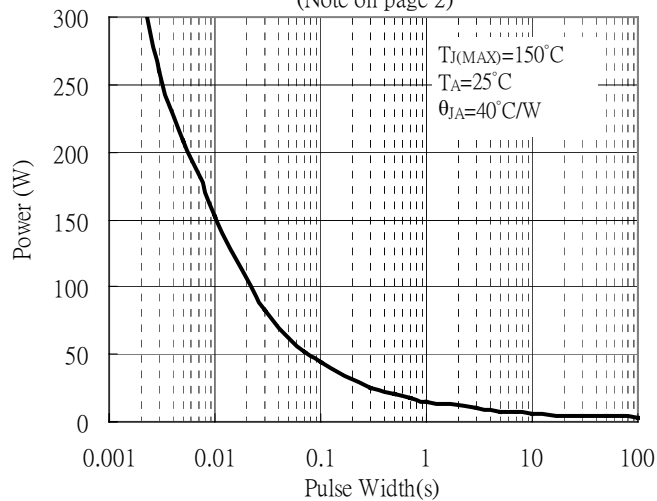


Maximum Drain Current vs Junction Temperature

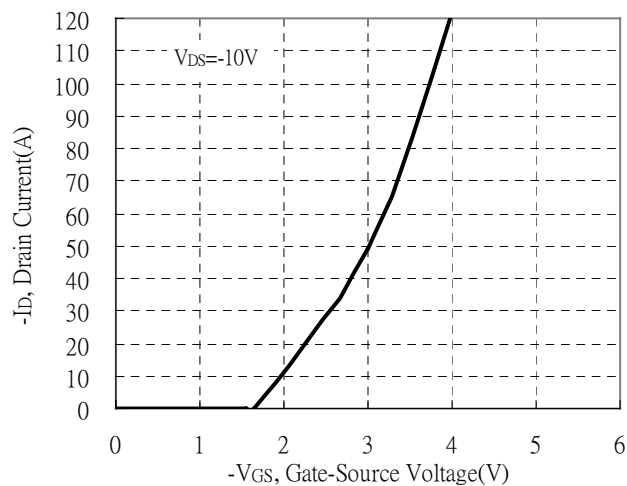


Typical Characteristics(Cont.)

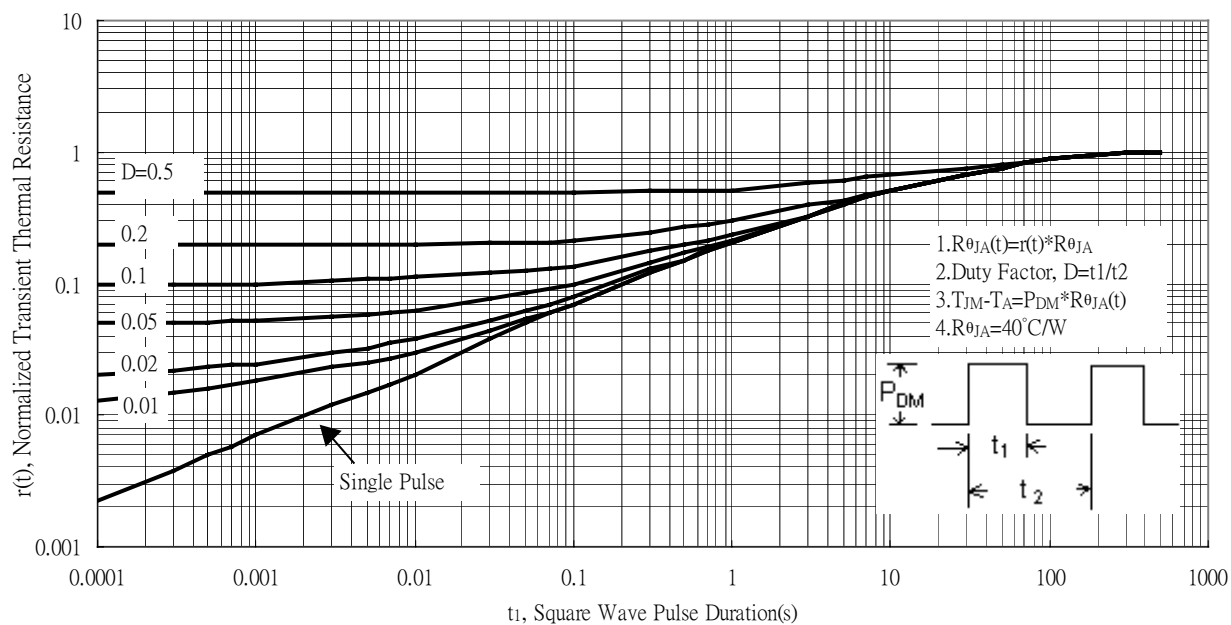
Single Pulse Power Rating, Junction to Ambient
 (Note on page 2)



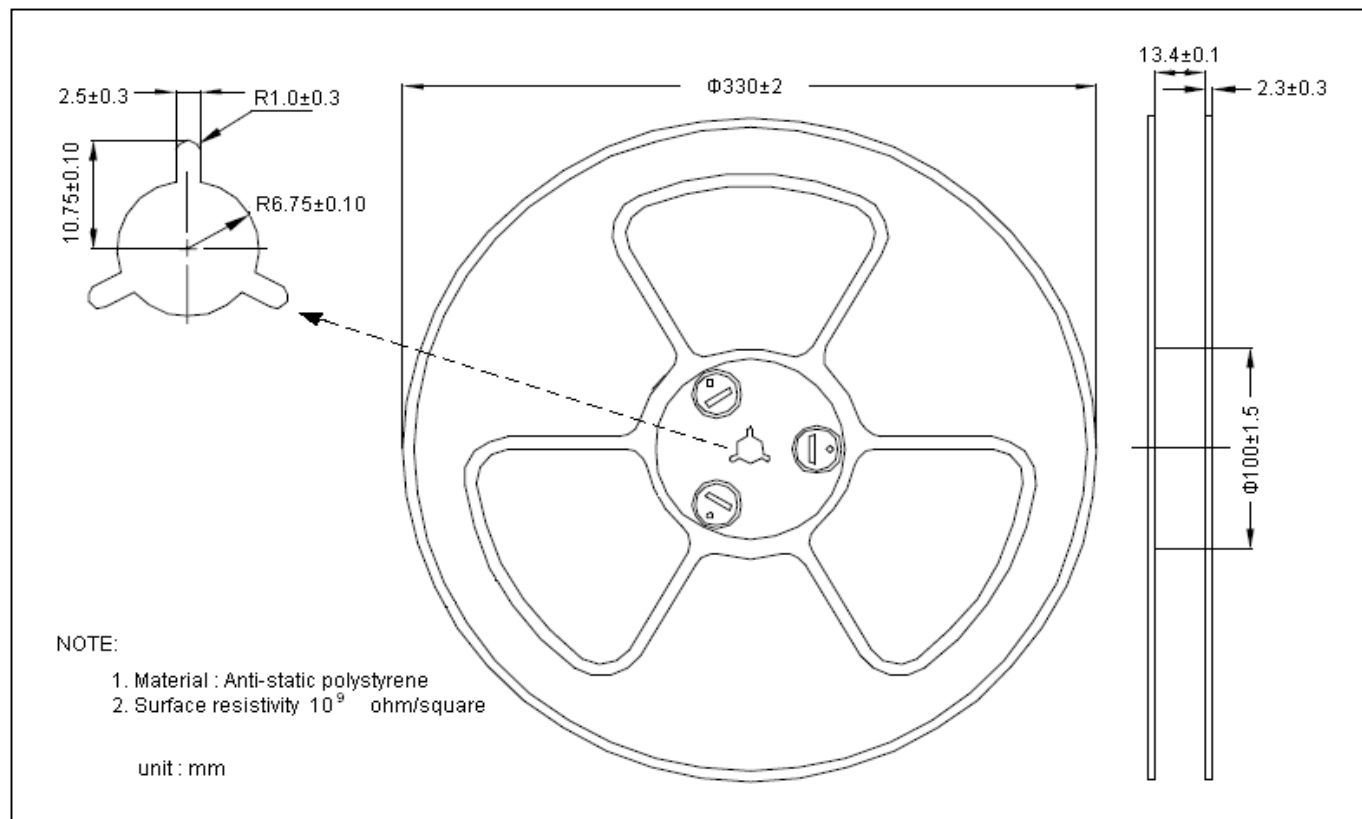
Typical Transfer Characteristics



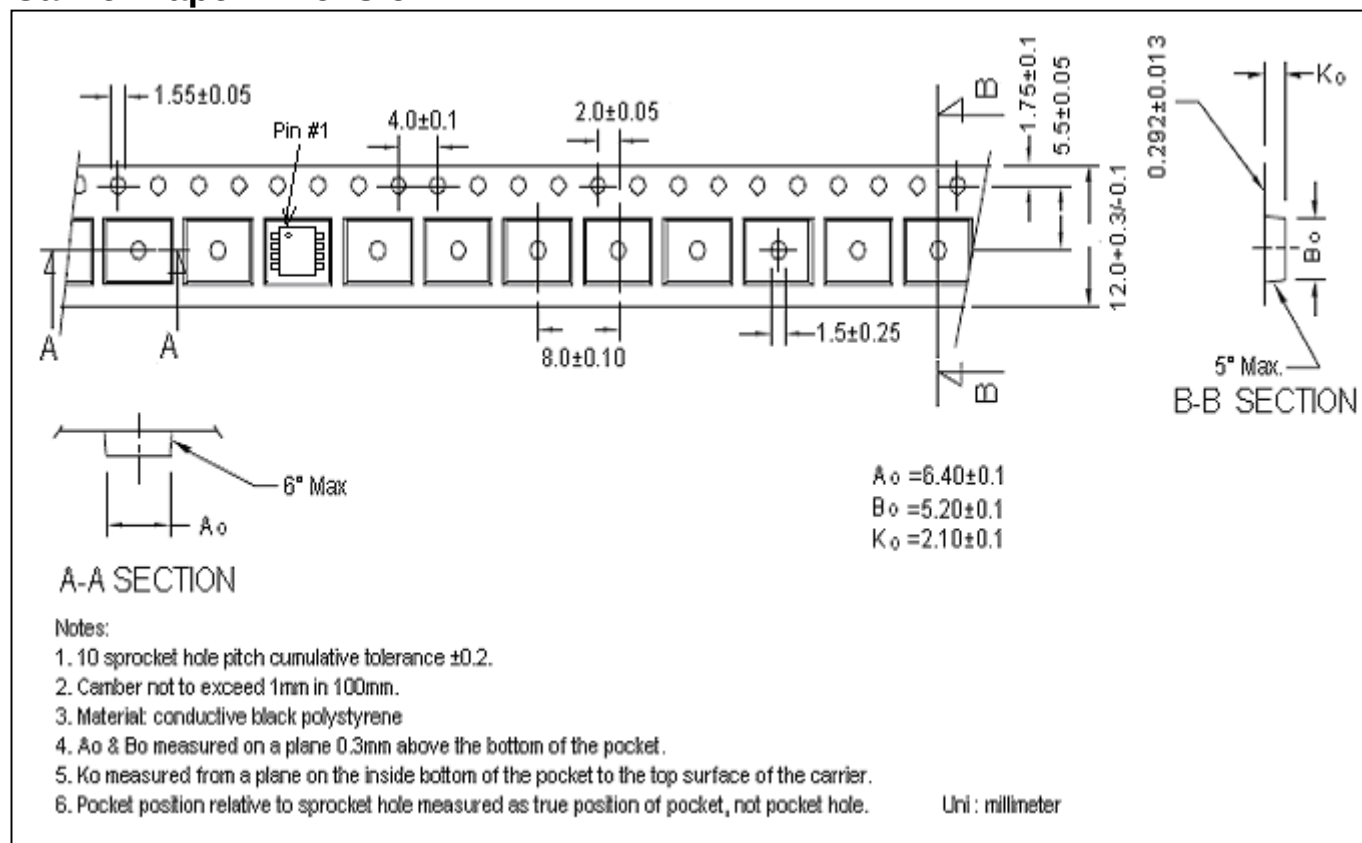
Transient Thermal Response Curves



Reel Dimension



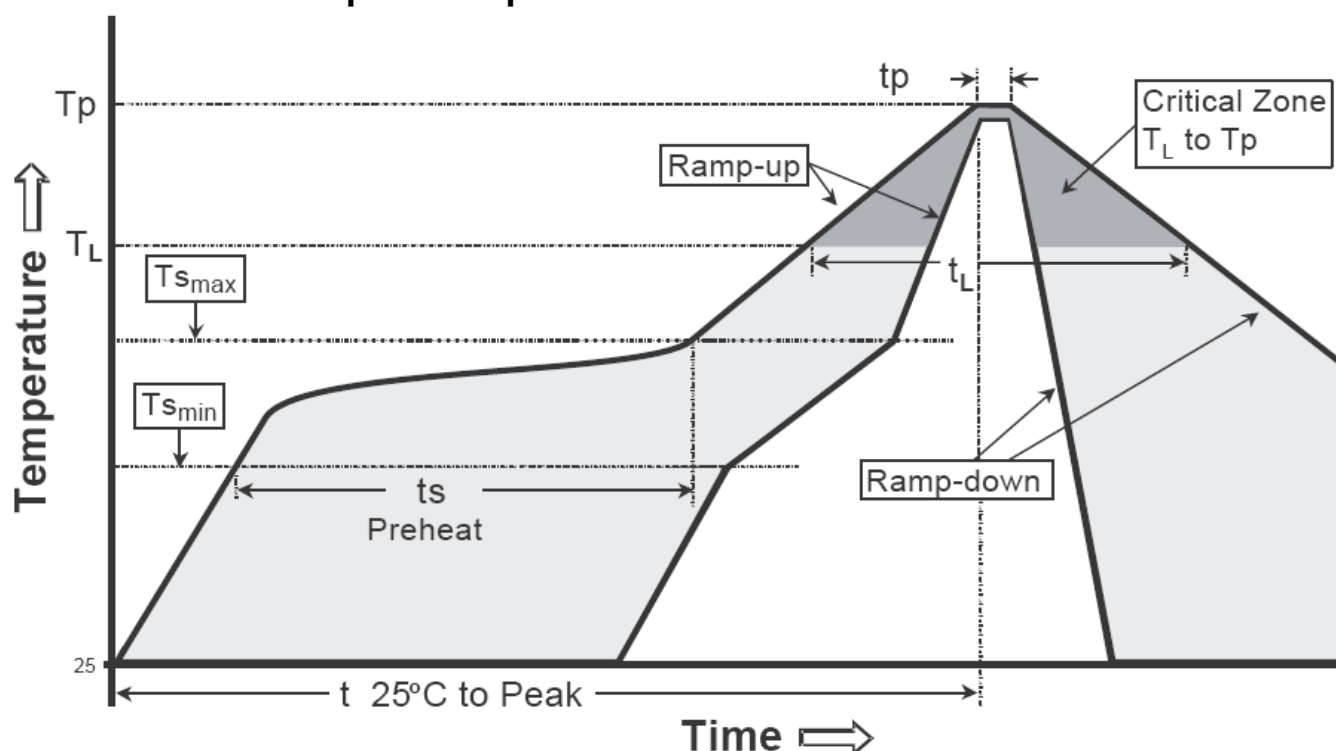
Carrier Tape Dimension



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

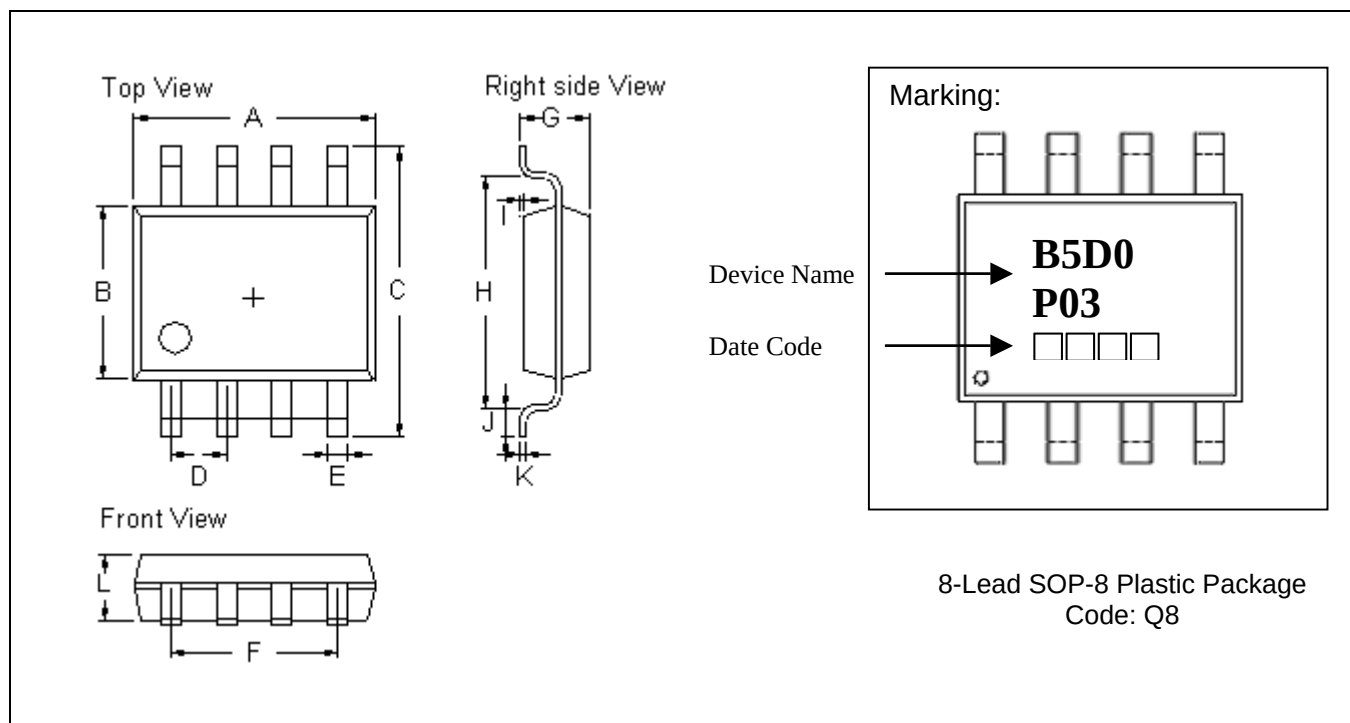
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Tsmax to Tp)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(ts min to ts max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (TL)	183°C	217°C
- Time (tL)	60-150 seconds	60-150 seconds
Peak Temperature(Tp)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

SOP-8 Dimension



*: Typical

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.1850	0.2007	4.70	5.10	G	0.0531	0.0689	1.35	1.75
B	0.1496	0.1575	3.80	4.00	H	0.1889	0.2007	4.80	5.10
C	0.2283	0.2441	5.80	6.20	I	0.0019	0.0098	0.05	0.25
D	0.0500*		1.27 *		J	0.0157	0.0500	0.40	1.27
E	0.0130	0.0201	0.33	0.51	K	0.0067	0.0098	0.17	0.25
F	0.1472	0.1527	3.74	3.88	L	0.0531	0.0610	1.35	1.55